

4GB, 8GB, 16GB: e·MMC Features

e·MMCTM Memory

MTFC4GACAAAM-1M WT MTFC8GACAAAM-1M WT MTFC16GAAAADV-2M WT

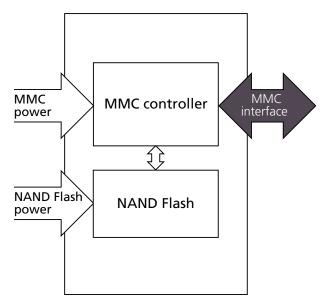
Features

- MultiMediaCard (MMC) controller and NAND Flash
- 153-ball VFBGA and 169-ball VFBGA (RoHS compliant, "green package")
- V_{CC}: 2.7-3.6V
- V_{CCO} (dual voltage): 1.65–1.95V; 2.7–3.6V
- Temperature ranges
 - Operating temperature: -25°C to +85°C
 - Storage temperature: -40°C to +85°C

MMC-Specific Features

- JEDEC/MMC standard version 4.51-compliant (JEDEC Standard No. 84-B451) – SPI mode not supported 1
 - Advanced 11-signal interface
 - x1, x4, and x8 I/Os, selectable by host
 - SDR/DDR modes up to 52 MHz clock speed
 - HS200 mode
 - Real-time clock
 - Command classes: class 0 (basic); class 2 (block read); class 4 (block write); class 5 (erase); class 6 (write protection); class 7 (lock card)
 - Temporary write protection
 - Boot operation (high-speed boot)
 - Sleep mode
 - Replay-protected memory block (RPMB)
 - Secure erase and secure trim
 - Hardware reset signal
 - Multiple partitions with enhanced attribute
 - Permanent and power-on write protection
 - High-priority interrupt (HPI)

Figure 1: Micron e·MMC Device



MMC-Specific Features (Continued)

- Background operation
- Reliable write
- Discard and sanitize
- Extended partitioning
- Context ID
- Data TAG
- Packed commands
- Dynamic device capacity
- Backward compatible with previous MMC
- Thermal specification
- Cache
- ECC and block management implemented

Note: 1. The JEDEC specification is available at www.jedec.org/sites/default/files/docs/ JESD84-B451.pdf.



4GB, 8GB, 16GB: e·MMC Features

e-MMC Performance and Current Consumption

Table 1: MLC Partition Performance

| | Typical Values | | | | | |
|------------------------|----------------|------|------|------|--|--|
| Condition ¹ | 4GB | 8GB | 16GB | Unit | | |
| Sequential Write | 11 | 24 | 24 | MB/s | | |
| Sequential Read | 80 | 120 | 120 | MB/s | | |
| Random Write | 1000 | 1000 | 1000 | IOPS | | |
| Random Read | 4000 | 4000 | 4000 | IOPS | | |

Note: 1. Bus in x8 I/O and HS200 modes. Sequential access of 1MB chunk; random access of 4KB chunk over 1GB span. Additional performance data, such as system performance on a specific application board, will be provided in a separate document upon customer request.

Table 2: 52 MHz DDR2 Performance

| | | Typical Values | | | | | |
|------------------------|------|----------------|------|------|--|--|--|
| Condition ¹ | 4GB | 8GB | 16GB | Unit | | | |
| Sequential Write | 11 | 24 | 24 | MB/s | | | |
| Sequential Read | 75 | 80 | 80 | MB/s | | | |
| Random Write | 1000 | 1000 | 1000 | IOPS | | | |
| Random Read | 3800 | 3800 | 3800 | IOPS | | | |

Note: 1. Bus in x8 I/O and 52 MHz DDR2 modes. Sequential access of 1MB chunk; random access of 4KB chunk over 1GB span. Additional performance data, such as system performance on a specific application board, will be provided in a separate document upon customer request.

Table 3: Current Consumption

| | Typical Values (I _{CC} /I _{CCQ}) | | | | | |
|------------------------|---|--------|--------|------|--|--|
| Condition ¹ | 4GB | 8GB | 16GB | Unit | | |
| Write | 50/20 | 60/20 | 60/20 | mA | | |
| Read | 60/60 | 60/60 | 60/60 | mA | | |
| Sleep | 0/180 | 0/180 | 0/180 | uA | | |
| Auto-Standby | 25/150 | 50/180 | 50/180 | uA | | |

Note: 1. Bus in x8 I/O and HS200 modes. $V_{CC} = 3.6V$ and $V_{CCQ} = 1.95V$. 25°C. Measurements done as average RMS current consumption. I_{CCQ} in READ operation might be affected by tester load.



4GB, 8GB, 16GB: e·MMC Features

Part Numbering Information

Micron®e·MMC memory devices are available in different configurations and densities.

Figure 2: e·MMC Part Numbering

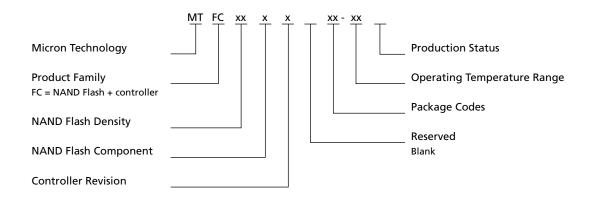


Table 4: Ordering Information

| Base Part Number | Density | Package | Shipping |
|---------------------|------------------------------|-------------------------|---------------|
| MTFC4GACAAAM-1M WT | 4GB | 153-ball VFBGA | Tray |
| | | 11.5mm x 13.0mm x 1.0mm | Tape and reel |
| MTFC8GACAAAM-1M WT | AAM-1M WT 8GB 153-ball VFBGA | | Tray |
| | | 11.5mm x 13.0mm x 1.0mm | Tape and reel |
| MTFC16GAAAADV-2M WT | 16GB | 169-ball VFBGA | Tray |
| | | 12.0mm x 16.0mm x 1.0mm | Tape and reel |

Device Marking

Due to the size of the package, the Micron-standard part number is not printed on the top of the device. Instead, an abbreviated device mark consisting of a 5-digit alphanumeric code is used. The abbreviated device marks are cross-referenced to the Micron part numbers at the FBGA Part Marking Decoder site: www.micron.com/decoder.



4GB, 8GB, 16GB: e·MMC General Description

General Description

Micron *e*·MMC is a communication and mass data storage device that includes a Multi-MediaCard (MMC) interface, a NAND Flash component, and a controller on an advanced 11-signal bus, which is compliant with the MMC system specification. Its low cost, small size, Flash technology independence, and high data throughput make *e*·MMC ideal for smartphones, digital cameras, PDAs, MP3s, and other portable applications.

The nonvolatile e·MMC draws no power to maintain stored data, delivers high performance across a wide range of operating temperatures, and resists shock and vibration disruption.



4GB, 8GB, 16GB: e⋅MMC Signal Descriptions

Signal Descriptions

Table 5: Signal Descriptions

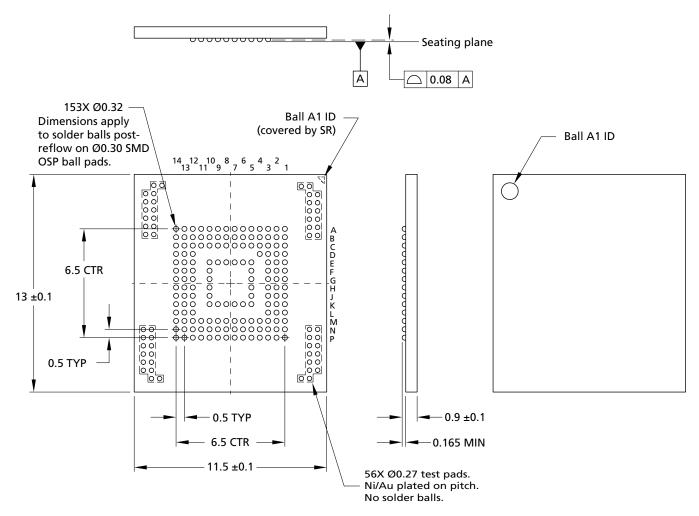
| Symbol | Туре | Description |
|-------------------------------|--------|--|
| CLK | Input | Clock: Each cycle of the clock directs a transfer on the command line and on the data line(s). The frequency can vary between the minimum and the maximum clock frequency. |
| RST_n | Input | Reset: The RST_n signal is used by the host for resetting the device, moving the device to the pre- idle state. By default, the RST_n signal is temporarily disabled in the device. The host must set ECSD register byte 162, bits[1:0] to 0x1 to enable this functionality before the host can use it. |
| CMD | I/O | Command: This signal is a bidirectional command channel used for command and response transfers. The CMD signal has two bus modes: open-drain mode and push-pull mode (see Operating Modes). Commands are sent from the MMC host to the device, and responses are sent from the device to the host. |
| DAT[7:0] | I/O | Data I/O: These are bidirectional data signals. The DAT signals operate in push-pull mode. By default, after power-on or assertion of the RST_n signal, only DAT0 is used for data transfer. The MMC controller can configure a wider data bus for data transfer either using DAT[3:0] (4-bit mode) or DAT[7:0] (8-bit mode). e·MMC includes internal pull-up resistors for data lines DAT[7:1]. Immediately after entering the 4-bit mode, the device disconnects the internal pull-up resistors on the DAT[3:1] lines. Upon entering the 8-bit mode, the device disconnects the internal pull-ups on the DAT[7:1] lines. |
| V _{CC} | Supply | V _{CC} : NAND interface (I/F) I/O and NAND Flash power supply. |
| V_{CCQ} | Supply | V _{CCQ} : e·MMC controller core and e·MMC I/F I/O power supply. |
| V _{SS} ¹ | Supply | V _{SS} : NAND I/F I/O and NAND Flash ground connection. |
| V _{SSQ} ¹ | Supply | V _{SSQ} : e·MMC controller core and e·MMC I/F ground connection. |
| V _{DDIM} | | Internal voltage node: At least a $0.1\mu F$ capacitor is required to connect V_{DDIM} to ground. A $1\mu F$ capacitor is recommended. Do not tie to supply voltage or ground. |
| NC | _ | No connect: No internal connection is present. |
| RFU | _ | Reserved for future use: No internal connection is present. Leave it floating externally. |

Note: 1. V_{SS} and V_{SSQ} are connected internally.



Package Dimensions

Figure 3: 153-Ball VFBGA - 11.50mm x 13.00mm x 1.00mm (Package Code: AM)



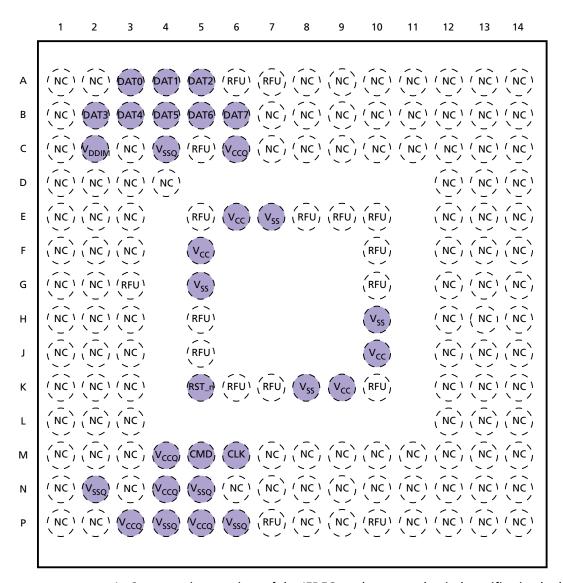
Note: 1. Dimensions are in millimeters.



4GB, 8GB, 16GB: e·MMC 153-Ball Signal Assignments

153-Ball Signal Assignments

Figure 4: 153 Ball (Top View, Ball Down)



Notes: 1. Some previous versions of the JEDEC product or mechanical specification had defined reserved for future use (RFU) balls as no connect (NC) balls. NC balls assigned in the previous specifications could have been connected to ground on the system board. To enable new feature introduction, some of these balls are assigned as RFU in the v4.4 mechanical specification. Any new PCB footprint implementations should use the new ball assignments and leave the RFU balls floating on the system board.

2. V_{CC} , V_{CCQ} , V_{SS} , and V_{SSQ} balls must all be connected on the system board.



4GB, 8GB, 16GB: e·MMC 169-Ball Signal Assignments

169-Ball Signal Assignments

Figure 5: 169 Ball (Top View, Ball Down)

| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 |
|----|------|---------------------|--------|-----------------------|-----------------------|-----------------------|------------|-----------------------|--------------------|--------------------|-----------------|------|------|------------|
| А | | | | (NC) | | (NC) | | | (NC) | | (NC) | | | |
| В | | (NC) | | $\overline{\bigcirc}$ | | $\overline{\bigcirc}$ | | | $\tilde{\bigcirc}$ | | $\overline{()}$ | | (NC) | |
| С | | () | | \bigcirc | | () | | | () | | () | | () | |
| D | (NC) | 0 | | 0 | | () | | | \bigcirc | | 0 | | () | (NC) |
| Ε | | () | | () | | | | | () | | | | | \bigcirc |
| F | | 0 | | () | | () | | | () | | | | () | \bigcirc |
| G | | 0 | | \bigcirc | | | | | () | | | | () | \bigcirc |
| н | (NC) | (NC) | DATO) | DAT1 | DAT2 | (RFU) | (RFU) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) |
| J | (NC) | DAT3 | DAT4 | DAT5 | DAT6 | DAT7 | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) |
| κ | (NC) | VDDIM | (NC) | (V _{sso}) | (RFU) | (v _{cco}) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) |
| L | (NC) | (NC) | (NC) | (NC) | | | | | | | | (NC) | (NC) | (NC) |
| М | (NC) | (NC) | (NC) | | (RFU) | (v _{cc}) | (v_{ss}) | (RFU) | (RFU) | (RFU) | | (NC) | (NC) | (NC) |
| N | (NC) | (NC) | (NC) | | (v_{cc}) | | | | | (RFU) | | (NC) | (NC) | (NC) |
| Р | (NC) | (NC) | (RFU) | | $\left(v_{ss}\right)$ | | | | | (RFU) | | (NC) | (NC) | (NC) |
| R | (NC) | (NC) | (NC) | | (RFU) | | | | | (V _{SS}) | | (NC) | (NC) | (NC) |
| Т | (NC) | (NC) | (NC) | | (RFU) | | | | | (v_{cc}) | | (NC) | (NC) | (NC) |
| U | (NC) | (NC) | (NC) | | RST_n | (RFU) | (RFU) | $\left(V_{SS}\right)$ | (v_{cc}) | (RFU) | | (NC) | (NC) | (NC) |
| ٧ | (NC) | (NC) | (NC) | | | | | | | | | (NC) | (NC) | (NC) |
| w | (NC) | (NC) | (NC) | (v _{cco}) | (CMD) | (CLK) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) |
| Υ | (NC) | (V _{ssQ}) | (NC) | (vcco) | (V _{ssQ}) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) | (NC) |
| AA | (NC) | (NC) | (vcco) | (V _{ssQ}) | (v _{cco}) | (V _{sso}) | (RFU) | (NC) | (NC) | (RFU) | (NC) | (NC) | (NC) | (NC) |
| АВ | | \bigcirc | | 0 | | () | | | () | | () | | () | () |
| AC | | \bigcirc | | () | | () | | | () | | () | | () | () |
| AD | | \bigcirc | | 0 | | | | | () | | () | | 0 | () |
| ΑE | (NC) | 0 | | () | | () | | | () | | () | | () | (NC) |
| AF | | 0 | | 0 | | 0 | | | () | | () | | () | |
| AG | | (NC) | | () | | () | | | 0 | | | | (NC) | |
| АН | | | | (NC) | | (NC) | | | (NC) | | (NC) | | | |
| | | | | | | | | | | | | | | |

Micron Confidential and Proprietary



4GB, 8GB, 16GB: e·MMC 169-Ball Signal Assignments

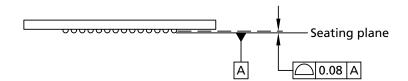
Notes:

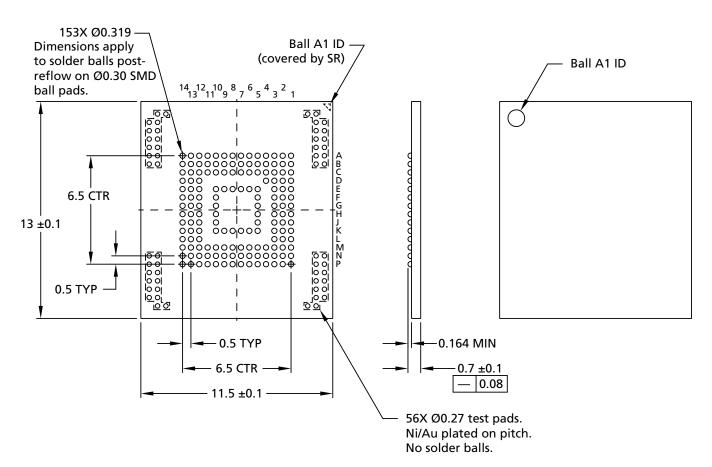
- 1. Empty balls do not denote actual solder balls; they are position indicators only.
- 2. Some previous versions of the JEDEC product or mechanical specification had defined reserved for future use (RFU) balls as no connect (NC) balls. NC balls assigned in the previous specifications could have been connected to ground on the system board. To enable new feature introduction, some of these balls are assigned as RFU in the v4.4 mechanical specification. Any new PCB footprint implementations should use the new ball assignments and leave the RFU balls floating on the system board.
- 3. V_{CC} , V_{CCQ} , V_{SS} , and V_{SSQ} balls must all be connected on the system board.



Package Dimensions

Figure 6: 153-Ball WFBGA - 11.5mm x 13.0mm x 0.8mm (Package Code: EA)



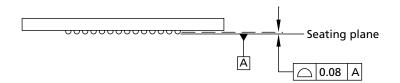


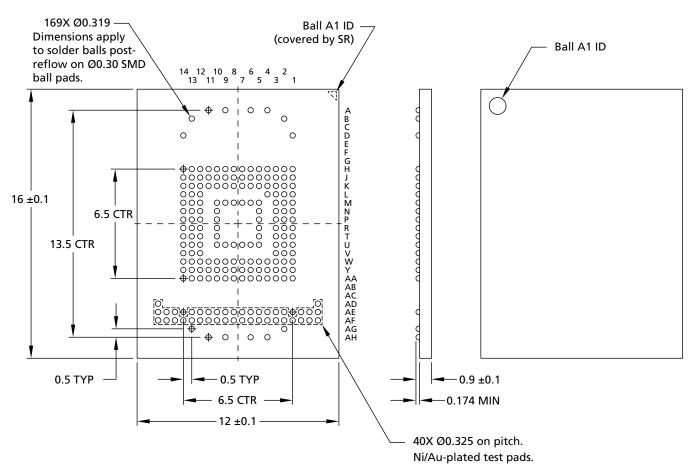
Note: 1. Dimensions are in millimeters.



Package Dimensions

Figure 7: 169-Ball VFBGA - 12.0mm x 16.0mm x 1.0mm (Package Code: DV)





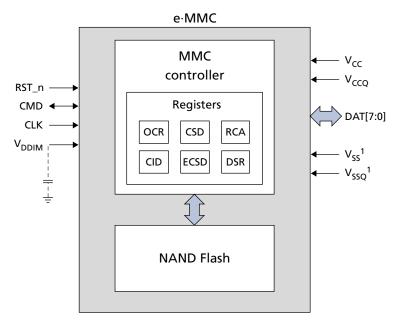
Note: 1. Dimensions are in millimeters.



4GB, 8GB, 16GB: e·MMC Architecture

Architecture

Figure 8: e-MMC Functional Block Diagram



Note: 1. V_{SS} and V_{SSO} are internally connected.

MMC Protocol Independent of NAND Flash Technology

The MMC specification defines the communication protocol between a host and a device. The protocol is independent of the NAND Flash features included in the device. The device has an intelligent on-board controller that manages the MMC communication protocol.

The controller also handles block management functions such as logical block allocation and wear leveling. These management functions require complex algorithms and depend entirely on NAND Flash technology (generation or memory cell type).

The device handles these management functions internally, making them invisible to the host processor.

Defect and Error Management

Micron *e*·MMC incorporates advanced technology for defect and error management. If a defective block is identified, the device completely replaces the defective block with one of the spare blocks. This process is invisible to the host and does not affect data space allocated for the user.

The device also includes a built-in error correction code (ECC) algorithm to ensure that data integrity is maintained.

To make the best use of these advanced technologies and ensure proper data loading and storage over the life of the device, the host must exercise the following precautions:

- Check the status after WRITE, READ, and ERASE operations.
- Avoid power-down during WRITE and ERASE operations.



OCR Register

The 32-bit operation conditions register (OCR) stores the $V_{\rm DD}$ voltage profile of the card and the access mode indication. In addition, this register includes a status information bit.

Table 6: OCR Parameters

| OCR Bits | OCR Value | Description |
|----------|-----------------------------------|------------------------------------|
| [31] | 1b (ready)/0b (busy) ¹ | Device power-on status bit |
| [30:29] | 10b | Sector mode |
| [28:24] | 0 0000b | Reserved |
| [23:15] | 1 1111 1111b | V _{DD} : 2.7–3.6V range |
| [14:8] | 000 0000b | V _{DD} : 2.0–2.7V range |
| [7] | 1b | V _{DD} : 1.70–1.95V range |
| [6:0] | 000 0000b | Reserved |

Note: 1. OCR = C0FF8080h after the device has completed power-up.



CID Register

The card identification (CID) register is 128 bits wide. It contains the device identification information used during the card identification phase as required by $e \cdot \text{MMC}$ protocol. Each device is created with a unique identification number.

Table 7: CID Register Field Parameters

| Name | Field | Width | CID Bits | CID Value |
|-----------------------|-------|-------|-----------|-----------|
| Manufacturer ID | MID | 8 | [127:120] | FEh |
| Reserved | _ | 6 | [119:114] | _ |
| Card/BGA | CBX | 2 | [113:112] | 01h |
| OEM/application ID | OID | 8 | [111:104] | 4Eh |
| Product name | PNM | 48 | [103:56] | P1xxxx |
| Product revision | PRV | 8 | [55:48] | _ |
| Product serial number | PSN | 32 | [47:16] | _ |
| Manufacturing date | MDT | 8 | [15:8] | _ |
| CRC7 checksum | CRC | 7 | [7:1] | _ |
| Not used; always 1 | _ | 1 | 0 | _ |



CSD Register

The card-specific data (CSD) register provides information about accessing the device contents. The CSD register defines the data format, error correction type, maximum data access time, and data transfer speed, as well as whether the DS register can be used. The programmable part of the register (entries marked with W or E in the following table) can be changed by the PROGRAM_CSD (CMD27) command.

Table 8: CSD Register Field Parameters

| Name | Field | | Size (Bits) | Cell Type ¹ | CSD Bits | CSD Value |
|--|--------------------|------|----------------|---------------------------|-------------|--------------|
| CSD structure | CSD_STRUCTURE | 2 | R | [127:126] | 03h | |
| System specification version | SPEC_VERS | | 4 | R | [125:122] | 04h |
| Reserved ² | _ | | 2 | _ | [121:120] | _ |
| Data read access time 1 | TAAC | | 8 | R | [119:112] | 4Fh |
| Data read access time 2 in CLK cycles (NSAC × 100) | NSAC | | 8 | R | [111:104] | 01h |
| Maximum bus clock frequency | TRAN_SPEED | | 8 | R | [103:96] | 32h |
| Card command classes ³ | ccc | | 12 | R | [95:84] | 0F5h |
| Maximum read data block length | READ_BL_LEN | | 4 | R | [83:80] | 09h |
| Partial blocks for reads supported | READ_BL_PARTIAL | | 1 | R | [79] | 0h |
| Write block misalignment | WRITE_BLK_MISALIGN | | 1 | R | [78] | 0h |
| Read block misalignment | READ_BLK_MISALIGN | | 1 | R | [77] | 0h |
| DSR implemented ⁴ | DSR_IMP | | 1 | R | [76] | 1h |
| Reserved | _ | | 2 | _ | [75:74] | _ |
| Device size | C_SIZE | | 12 | R | [73:62] | FFFh |
| Maximum read current at V _{DD,min} | VDD_R_CURR_MIN | | 3 | R | [61:59] | 07h |
| Maximum read current at V _{DD,max} | VDD_R_CURR_MAX | | 3 | R | [58:56] | 07h |
| Maximum write current at V _{DD,min} | VDD_W_CURR_MIN | | 3 | R | [55:53] | 07h |
| Maximum write current at V _{DD,max} | VDD_W_CURR_MAX | | 3 | R | [52:50] | 07h |
| Device size multiplier | C_SIZE_MULT | | 3 | R | [49:47] | 07h |
| Erase group size | ERASE_GRP_SIZE | | 5 | R | [46:42] | 1Fh |
| Erase group size multiplier | ERASE_GRP_MULT | | 5 | R | [41:37] | 1Fh |
| Write protect group size | WP_GRP_SIZE | 4GB | 5 | R | [36:32] | 07h |
| | | 8GB | 1 | | | 0Fh |
| | | 16GB | 1 | | | 1Fh |
| Write protect group enable | WP_GRP_ENABLE | 1 | R | [31] | 1h | |
| Manufacturer default ECC | DEFAULT_ECC | 2 | R | [30:29] | 00h | |
| Write-speed factor | R2W_FACTOR | 3 | R | [28:26] | 02h | |
| Maximum write data block length | WRITE_BL_LEN | 4 | R | [25:22] | 09h | |
| Partial blocks for writes supported | WRITE_BL_PARTIAL | 1 | R | [21] | 0h | |
| Reserved | - | | 4 | _ | [20:17] | - |
| Content protection application | CONTENT_PROT_APP | | 1 | R | [16] | 0h |



Table 8: CSD Register Field Parameters (Continued)

| Name | Field | | Size (Bits) | Cell Type ¹ | CSD Bits | CSD Value |
|----------------------------|--------------------|------|----------------|---------------------------|-------------|--------------|
| | | | (Bits) | | | |
| File-format group | FILE_FORMAT_GRP | | 1 | R/W | [15] | 0h |
| Copy flag (OTP) | COPY | | 1 | R/W | [14] | 0h |
| Permanent write protection | PERM_WRITE_PROTECT | | 1 | R/W | [13] | 0h |
| Temporary write protection | TMP_WRITE_PROTECT | | 1 | R/W/E | [12] | 0h |
| File format | FILE_FORMAT | | 2 | R/W | [11:10] | 00h |
| ECC | ECC | | 2 | R/W/E | [9:8] | 00h |
| CRC | CRC | 4GB | 7 | R/W/E | [7:1] | 47h |
| | | 8GB | | | | 5Fh |
| | | 16GB | | | | 6Fh |
| Reserved | _ | | 1 | _ | [0] | - |

- Notes: 1. R = Read-only;
 - R/W = One-time programmable and readable;

R/W/E = Multiple writable with value kept after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable

- 2. Reserved bits should be read as 0.
- 3. CM0 restriction: CMD0 (SW RESET) is not supported during programming command. If SW RESET is issued during programming commands, a power cycle is required.
- 4. The $I_{PEAK, max}$ driving capability can be modified according to the actual capacitive load on the e-MMC interface signals in the user application board, using CMD4. In HS200 mode, the driver strength value is set in EXT_CSD[185], using CMD6.

| CMD4 Argument | Driving Capability (mA) |
|---------------|-------------------------|
| 0x01000000 | 4 |
| 0x02000000 | 8 |
| 0x04000000 | 12 (default) |
| 0x08000000 | 16 |
| 0x10000000 | 20 |
| 0x20000000 | 24 |
| 0x40000000 | 28 |
| 0x80000000 | 32 |



ECSD Register

The 512-byte extended card-specific data (ECSD) register defines device properties and selected modes. The most significant 320 bytes are the properties segment. This segment defines device capabilities and cannot be modified by the host. The lower 192 bytes are the modes segment. The modes segment defines the configuration in which the device is working. The host can change the properties of modes segments using the SWITCH command.

Table 9: ECSD Register Field Parameters

| Name | Field | | Size (Bytes) | Cell Type ¹ | ECSD Bytes | ECSD Value |
|---|---------------------------------|------|-----------------|---------------------------|---------------|---------------|
| Properties Segment | | | | | | |
| Reserved ² | _ | | 6 | _ | [511:506] | _ |
| Extended security protocol | EXT_SECURITY_ERR | | 1 | R | [505] | 00h |
| Supported command sets | S_CMD_SET | | 1 | R | [504] | 01h |
| HPI features | HPI_FEATURES | | 1 | R | [503] | 03h |
| Background operations support | BKOPS_SUPPORT | | 1 | R | [502] | 01h |
| Max-packed read commands | MAX_PACKED_READS | | 1 | R | [501] | 3Ch |
| Max-packed write commands | MAX_PACKED_WRITES | | 1 | R | [500] | 3Ch |
| Data tag support | DATA_TAG_SUPPORT | | 1 | R | [499] | 01h |
| Tag unit size | TAG_UNIT_SIZE | | 1 | R | [498] | 03h |
| Tag resources size | TAG_RES_SIZE | | 1 | R | [497] | 00h |
| Context management capabilities | CONTEXT_CAPABILITIES | | 1 | R | [496] | 05h |
| Large unit size | LARGE_UNIT_SIZE_M1 | 4GB | 1 | R | [495] | 03h |
| | | 8GB | | | | 07h |
| | | 16GB | | | | 07h |
| Extended partitions attribute support | EXT_SUPPORT | | 1 | R | [494] | 03h |
| Reserved | - | | 241 | _ | [493:253] | _ |
| Cache size | CACHE_SIZE | | 4 | R | [252:249] | 00000020h |
| Generic CMD6 timeout | GENERIC_CMD6_TIME | | 1 | R | [248] | 19h |
| Power-off notification (long) timeout | POWER_OFF_LONG_TIME | | 1 | R | [247] | FFh |
| Background operations status | BKOPS_STATUS | | 1 | R | [246] | 00h |
| Number of correctly programmed sectors | CORRECTLY_PROG_SEC- TORS_NUM | | 4 | R | [245:242] | 00000000h |
| First initialization time after partitioning (first CMD1 to device ready) | INI_TIMEOUT_AP | | 1 | R | [241] | 32h |
| Reserved | - | | 1 | - | [240] | - |
| Power class for 52 MHz, DDR at 3.6V | PWR_CL_DDR_52_360 | | 1 | R | [239] | 04h |
| Power class for 52 MHz, DDR at 1.95V | PWR_CL_DDR_52_195 | | 1 | R | [238] | 09h |
| Power class for 200 MHz at 1.95V | PWR_CL_200_195 | | 1 | R | [237] | 09h |
| Power class for 200 MHz, at 1.3V | PWR_CL_200_130 | | 1 | R | [236] | 00h |



Table 9: ECSD Register Field Parameters (Continued)

| Name | Field | | Size (Bytes) | Cell Type ¹ | ECSD Bytes | ECSD Value |
|---|----------------------|----------------|-----------------|---------------------------|---------------|---------------|
| Minimum write performance for 8-bit at 52 MHz in DDR mode | MIN_PERF_DDR_W_8_52 | | 1 | R | [235] | 00h |
| Minimum read performance for 8-bit at 52 MHz in DDR mode | MIN_PERF_DDR_R_8_52 | | 1 | R | [234] | 00h |
| Reserved | _ | _ | | _ | [233] | _ |
| TRIM multiplier | TRIM_MULT | | 1 | R | [232] | 03h |
| Secure feature support | SEC_FEATURE_SUPPORT | | 1 | R | [231] | 55h |
| Secure erase multiplier | SEC_ERASE_MULT | | 1 | R | [230] | 06h |
| Secure trim multiplier | SEC_TRIM_MULT | | 1 | R | [229] | 09h |
| Boot information | BOOT_INFO | | 1 | R | [228] | 07h |
| Reserved | _ | | 1 | _ | [227] | _ |
| Boot partition size | BOOT_SIZE_MULT | 4GB | 1 | R | [226] | 10h |
| | | 8GB | | | | 10h |
| | | 16GB | | | | 20h |
| Access size | ACC_SIZE | 4GB | 1 | R | [225] | 06h |
| | | 8GB | | | | 07h |
| | | 16GB | | | | 07h |
| High-capacity erase unit size | HC_ERASE_GRP_SIZE | 4GB | 1 | R | [224] | 08h |
| | | 8GB | | | | 10h |
| | | 16GB | | | | 10h |
| High-capacity erase timeout | ERASE_TIMEOUT_MULT | | 1 | R | [223] | 01h |
| Reliable write-sector count | REL_WR_SEC_C | | 1 | R | [222] | 01h |
| High-capacity write protect group size | HC_WP_GRP_SIZE | HC_WP_GRP_SIZE | | R | [221] | 01h |
| Sleep current (V _{CC}) | S_C_VCC | | 1 | R | [220] | 06h |
| Sleep current (V _{CCQ}) | S_C_VCCQ | | 1 | R | [219] | 09h |
| Reserved | - | | 1 | - | [218] | _ |
| Sleep/awake timeout | S_A_TIMEOUT | | 1 | R | [217] | 10h |
| Reserved | - | | 1 | - | [216] | _ |
| Sector count | SEC_COUNT | 4GB | 4 | R | [215:212] | 00734000h |
| | | 8GB | | | | 00E68000h |
| | | 16GB | | | | 01CD0000h |
| Reserved | - | | 1 | _ | [211] | _ |
| Minimum write performance for 8-bit at 52 MHz | MIN_PERF_W_8_52 | | 1 | R | [210] | 08h |
| Minimum read performance for 8-bit at 52 MHz | MIN_PERF_R_8_52 | | 1 | R | [209] | 08h |
| Minimum write performance for 8-bit at 26 MHz and 4-bit at 52 MHz | MIN_PERF_W_8_26_4_52 | | 1 | R | [208] | 08h |



Table 9: ECSD Register Field Parameters (Continued)

| | | Size | Cell | ECSD | ECSD |
|--|-----------------------|---------|-------------------|-------|-------|
| Name | Field | (Bytes) | Type ¹ | Bytes | Value |
| Minimum read performance for 8-bit at 26 MHz and 4-bit at 52 MHz | MIN_PERF_R_8_26_4_52 | 1 | R | [207] | 08h |
| Minimum write performance for 4-bit at 26 MHz | MIN_PERF_W_4_26 | 1 | R | [206] | 08h |
| Minimum read performance for 4-bit at 26 MHz | MIN_PERF_R_4_26 | 1 | R | [205] | 08h |
| Reserved | - | 1 | - | [204] | _ |
| Power class for 26 MHz at 3.6V | PWR_CL_26_360 | 1 | R | [203] | 02h |
| Power class for 52 MHz at 3.6V | PWR_CL_52_360 | 1 | R | [202] | 02h |
| Power class for 26 MHz at 1.95V | PWR_CL_26_195 | 1 | R | [201] | 05h |
| Power class for 52 MHz at 1.95V | PWR_CL_52_195 | 1 | R | [200] | 05h |
| Partition switching timing | PARTITION_SWITCH_TIME | 1 | R | [199] | 03h |
| Out-of-interrupt busy timing | OUT_OF_INTERRUPT_TIME | 1 | R | [198] | 0Ah |
| I/O driver strength | DRIVER_STRENGTH | 1 | R | [197] | 0Fh |
| Card type | CARD_TYPE | 1 | R | [196] | 17h |
| Reserved | _ | 1 | _ | [195] | _ |
| CSD structure version | CSD_STRUCTURE | 1 | R | [194] | 02h |
| Reserved | - | 1 | _ | [193] | _ |
| Extended CSD revision | EXT_CSD_REV | 1 | R | [192] | 06h |
| Modes Segment | 1 | | | | |
| Command set | CMD_SET | 1 | R/W/E_P | [191] | 00h |
| Reserved | - | 1 | _ | [190] | _ |
| Command set revision | CMD_SET_REV | 1 | R | [189] | 00h |
| Reserved | _ | 1 | _ | [188] | _ |
| Power class | POWER_CLASS | 1 | R/W/E_P | [187] | 00h |
| Reserved | - | 1 | _ | [186] | _ |
| High-speed interface timing ⁴ | HS_TIMING | 1 | R/W/E_P | [185] | 00h |
| Reserved | - | 1 | _ | [184] | _ |
| Bus width mode | BUS_WIDTH | 1 | W/E_P | [183] | 00h |
| Reserved | - | 1 | _ | [182] | _ |
| Erased memory content | ERASED_MEM_CONT | 1 | R | [181] | 00h |
| Reserved | _ | 1 | _ | [180] | _ |
| Partition configuration | PARTITION_CONFIG | 1 | R/W/E, R/W/E_P | [179] | 00h |
| Boot configuration protection | BOOT_CONFIG_PROT | 1 | R/W, R/W/C_P | [178] | 00h |
| Boot bus width | BOOT_BUS_WIDTH | 1 | R/W/E | [177] | 00h |
| Reserved | - | 1 | _ | [176] | _ |



Table 9: ECSD Register Field Parameters (Continued)

| | | Size | Cell | ECSD | ECSD |
|---|----------------------------------|-------------------------|-------------------------------|-----------|-----------|
| Name | Field | (Bytes) | Type ¹ | Bytes | Value |
| High-density erase group definition | ERASE_GROUP_DEF | 1 | R/W/E_P | [175] | 00h |
| Boot write protection status registers | BOOT_WP_STATUS | OOT_WP_STATUS 1 R [174] | | 00h | |
| Boot area write protection register | BOOT_WP | 1 | R/W, R/W/C_P | [173] | 00h |
| Reserved | - | 1 | _ | [172] | _ |
| User write protection register | USER_WP | 1 | R/W, R/W/C_P, R/W/E_P | [171] | 00h |
| Reserved | _ | 1 | _ | [170] | _ |
| Firmware configuration | FW_CONFIG | 1 | R/W | [169] | 00h |
| RPMB size | RPMB_SIZE_MULT | 1 | R | [168] | 01h |
| Write reliability setting register ³ | WR_REL_SET | 1 | R/W | [167] | 00h |
| Write reliability parameter register | WR_REL_PARAM | 1 | R | [166] | 05h |
| SANITIZE START operation | SANITIZE_START | 1 | W/E_P | [165] | 00h |
| Manually start background operations | BKOPS_START | 1 | W/E_P | [164] | 00h |
| Enable background operations hand- shake | BKOPS_EN | 1 | R/W | [163] | 00h |
| Hardware reset function | RST_n_FUNCTION | 1 | R/W | [162] | 00h |
| HPI management | HPI_MGMT | 1 | R/W/E_P | [161] | 00h |
| Partitioning support | PARTITIONING_SUPPORT | 1 | R | [160] | 07h |
| Maximum enhanced area size | MAX_ENH_SIZE_MULT | 3 | R | [159:157] | 0001CDh |
| Partitions attribute | PARTITIONS_ATTRIBUTE | 1 | R/W | [156] | 00h |
| Partitioning setting | PARTITION_SETTING_COMPLETED | 1 | R/W | [155] | 00h |
| General-purpose partition size | GP_SIZE_MULT_GP3 | 12 | R/W | [154:152] | 000000h |
| | GP_SIZE_MULT_GP2 | | | [151:149] | 000000h |
| | GP_SIZE_MULT_GP1 | | | [148:146] | 000000h |
| | GP_SIZE_MULT_GP0 | | | [145:143] | 000000h |
| Enhanced user data area size | ENH_SIZE_MULT | 3 | R/W | [142:140] | 000000h |
| Enhanced user data start address | ENH_START_ADDR | 4 | R/W | [139:136] | 00000000h |
| Reserved | - | 1 | _ | [135] | _ |
| Bad block management mode | SEC_BAD_BLK_MGMNT | 1 | R/W | [134] | 00h |
| Reserved | - | 1 | _ | [133] | _ |
| Package case temperature is controlled | TCASE_SUPPORT | 1 | W/E_P | [132] | 00h |
| Periodic wake-up | PERIODIC_WAKEUP | 1 | R/W/E | [131] | 00h |
| Program CID/CSD in DDR mode support | PROGRAM_CID_CSD_DDR_SUP- PORT | 1 | R | [130] | 01h |
| Reserved | - | 2 | TBD | [129:128] | TBD |
| Vendor specific fields | VENDOR_SPECIFIC_FIELD | 64 | <vendor specific=""></vendor> | [127:64] | TBD |



Table 9: ECSD Register Field Parameters (Continued)

| Name | Field | Size (Bytes) | Cell Type ¹ | ECSD Bytes | ECSD Value |
|--|--------------------------|-----------------|---------------------------|---------------|---------------|
| Native sector size | NATIVE_SECTOR_SIZE | 1 | R | [63] | 00h |
| Sector size emulation | USE_NATIVE_SECTOR | 1 | R/W | [62] | 00h |
| Sector size | DATA_SECTOR_SIZE | 1 | R | [61] | 00h |
| 1st initialization after disabling sector size emulation | INI_TIMEOUT_EMU | 1 | R | [60] | 0Ah |
| Class 6 commands control | CLASS_6_CTRL | 1 | R/W/E_P | [59] | 00h |
| Number of addressed group to be re- leased | DYNCAP_NEEDED | 1 | R | [58] | 00h |
| Exception events control | EXCEPTION_EVENTS_CTRL | 2 | R/W/E_P | [57:56] | 00h |
| Exception events status | EXCEPTION_EVENTS_STATUS | 2 | R | [55:54] | 00h |
| Extended partitions attribute | EXT_PARTITIONS_ATTRIBUTE | 2 | R/W | [53:52] | 00h |
| Context configuration | CONTEXT_CONF | 15 | R/W/E_P | [51:37] | 00h |
| Packed command status | PACKED_COMMAND_STATUS | 1 | R | [36] | 00h |
| Packed command failure index | PACKED_FAILURE_INDEX | 1 | R | [35] | 00h |
| Power-off notification | POWER_OFF_NOTIFICATION | 1 | R/W/E_P | [34] | 00h |
| Control to turn the Cache ON/OFF | CACHE_CTRL | 1 | R/W/E_P | [33] | 00h |
| Flushing of the cache | FLUSH_CACHE | 1 | W/E_P | [32] | 00h |
| Reserved | - | 32 | TBD | [31:0] | - |

Notes: 1. R = Read-only;

R/W = One-time programmable and readable;

R/W/E = Multiple writable with the value kept after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable;

R/W/C_P = Writable after the value is cleared by a power cycle and assertion of the RST_n signal (the value not cleared by CMD0 reset) and readable;

R/W/E_P = Multiple writable with the value reset after a power cycle, assertion of the RST_n signal, and any CMD0 reset, and readable;

W/E_P = Multiple writable with the value reset after power cycle, assertion of the RST_n signal, and any CMD0 reset, and not readable

- 2. Reserved bits should be read as 0.
- 3. Micron has tested power failure under best-application knowledge conditions with positive results. Customers may request a dedicated test for their specific application condition. Micron set this register during factory test and used the one-time programming option.
- 4. ^tIH parameter in HS200 is 1.4ns. Refer to the JEDEC specification for the output timing diagram.



4GB, 8GB, 16GB: e·MMC DC Electrical Specifications – Device Power

DC Electrical Specifications – Device Power

The device current consumption for various device configurations is defined in the power class fields of the ECSD register.

 V_{CC} is used for the NAND Flash device and its interface voltage; V_{CCQ} is used for the controller and the e-MMC interface voltage.

Figure 9: Device Power Diagram

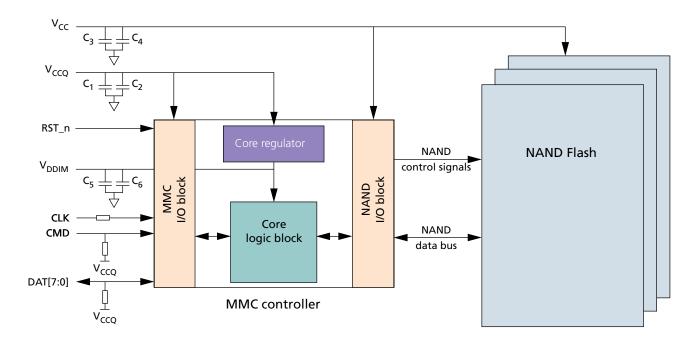


Table 10: Absolute Maximum Ratings

| Parameters | Symbol | Min | Max | Unit |
|-------------------------|-----------|------|-----|------|
| Voltage input | V_{IN} | -0.6 | 4.6 | V |
| V _{CC} supply | V_{CC} | -0.6 | 4.6 | V |
| V _{CCQ} supply | V_{CCQ} | -0.6 | 4.6 | V |

Table 11: Power Domains

| Parameter | Symbol | Comments |
|----------------|-------------------|--|
| Host interface | V _{CCQM} | High voltage range = 3.3V (nominal) Low voltage range = 1.8V (nominal) |
| Memory | V _{CCM} | High voltage range = 3.3V (nominal) |
| Internal | V _{DDIM} | The internal regulator connection to an external decoupling capacitor |



4GB, 8GB, 16GB: e⋅MMC **DC Electrical Specifications – Device Power**

Table 12: Capacitor and Resistance Specifications

| Parameter | Symbol | Min | Max | Тур | Units | Notes |
|---|---------|-----|------|------|-------|-------|
| Pull-up resistance: CMD | R_CMD | 4.7 | 50 | 10 | kΩ | 1 |
| Pull-up resistance: DAT[7:0] | R_DAT | 10 | 50 | 50 | kΩ | 1 |
| Pull-up resistance: RST_n | R_RST_n | 4.7 | 50 | 50 | kΩ | 2 |
| CLK/CMD/DAT[7:0] impedance | | 45 | 55 | 50 | Ω | 3 |
| Serial resistance on CLK | SR_CLK | 0 | 47 | 22 | Ω | |
| V _{CCQ} capacitor | C1 | 2.2 | 4.7 | 2.2 | μF | 4 |
| | C2 | 0.1 | 0.22 | 0.1 | | |
| V _{CC} capacitor (≤8GB) | C3 | 2.2 | 4.7 | 2.2 | μF | 5 |
| | C4 | 0.1 | 0.22 | 0.1 | | |
| V _{CC} capacitor (>8GB) | C3 | 2.2 | 4.7 | 4.7 | μF | 5 |
| | C4 | 0.1 | 0.22 | 0.22 | | |
| V _{DDIM} capacitor (C _{reg}) | C5 | 1 | 4.7 | 1 | μF | 6 |
| | C6 | 0.1 | 0.1 | 0.1 | | |

- Notes: 1. Used to prevent bus floating.
 - 2. If host does not use H/W RESET (RST_n), pull-up resistance is not needed on RST_n line $(Extended_CSD[162] = 00h).$
 - 3. Impedance match.
 - 4. The coupling capacitor should be connected with V_{CCQ} and V_{SSQ} as closely as possible.
 - 5. The coupling capacitor should be connected with V_{CC} and V_{SS} as closely as possible.
 - 6. The coupling capacitor should be connected with V_{DDIM} and V_{SS} as closely as possible.



4GB, 8GB, 16GB: e⋅MMC Revision History

Revision History

Rev. F - 06/14

• Added the 153-Ball Signal Assignment figure

Rev. E - 06/14

• Changed the ^tIH value from 1.0ns to 1.4ns.

Rev. D - 04/14

Added the "Absolute Maximum Ratings" table to the DC Electrical Specifications section

Rev. C - 02/14

• Removed "Preliminary" from the document and promoted to "Production" status

Rev. B - 11/13

- Added MTFC16GAAAADV-2M WT to the subtitle
- Added "16MB" columns and specs to the Performance and Current Consumption tables
- Added the MTFC16GAAAADV-2M WT specific information to the Ordering Information table
- Added the 169 ball Signal Assignments figure and the 169 ball Package Dimensions figure
- Added 16MB specifications to the CSD and ECSD register tables

Rev. A - 10/13

· Initial release

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